
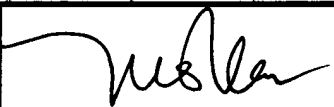
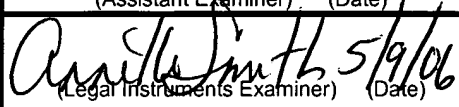


<b>Issue Classification</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	09/651,944	DRAPKIN ET AL.	
	<b>Examiner</b>	<b>Art Unit</b>	
	Hiep Nguyen	2816	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
327		382		327	379	380	381		
INTERNATIONAL CLASSIFICATION									
H	0	3	K	17/16					
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Hiep Nguyen (Assistant Examiner) (Date)		 <b>TUAN T. LAM</b> PRIMARY EXAMINER (Primary Examiner)	<b>Total Claims Allowed: 7</b>	
 Annelle Smith (Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 2C

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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